

FORM PTO-1449 (Modified)			Docket No.: 200310474-1		Serial No.: <u>10/665,189</u>		
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT			Applicant: Nauka et al.				
			Title: SURFACE PHOTOVOLTAGE-BASED SENSING OF MOLECULES				
			Filing Date:		Art Unit:		
<b>UNITED STATES PATENT DOCUMENTS</b>							
*Exr's. Init.	Ref.	Patent No.	Date	Name	Class	Sub Class	Filing Date (if applicable)
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
<b>FOREIGN PATENT DOCUMENTS</b>							
Exr's. Init.	Ref	Document No.	Date	Country	Class	Sub	Translation? Yes No
	AH						
	AI						
<b>OTHER REFERENCES (Including Author, Date, Title, Pertinent Pages, Etc.)</b>							
Exr's. Init.	Ref.	Bibliographic Data					
<i>[Signature]</i>	AJ	Danny Banks, "Introduction to Microengineering", <a href="http://www.dbanks.demon.co.uk/ueng/chemsens.html">www.dbanks.demon.co.uk/ueng/chemsens.html</a> "					
<i>[Signature]</i>	AK	Stetter et al. "Sensors, Chemical Sensors, Electrochemical sensors, and ECS", Journal of Electrochemical Society, 150 (2) S11-S16 (2003)					
<i>[Signature]</i>	AL	"Chemical and biochemical sensors" Ullmann's Encyclopedia of Industrial Chemistry, Wiley-VCH Verlag GnbH&Co. (2001)					
<i>[Signature]</i>	AM	Hayley Lam, "Microelectromechanical chemical sensors", National Nanofabrication Users Network					
<i>[Signature]</i>	AN	Ho et al., "Review of chemical sensors for in-situ monitoring of volatile contaminants", Sandia National Laboratory, SAND2001-0643 (March 2001)					
<i>[Signature]</i>	AO	"Micro-chemical sensors for in-situ monitoring and characterization of volatile contaminants", <a href="http://www.sandia.gov.sensor/MainPage.htm">www.sandia.gov.sensor/MainPage.htm</a>					
Examiner <i>[Signature]</i>				Date Considered <u>2/24/2006</u>			
<p>* Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. ¶ 609. Draw line through citation (i.e., <del>citation</del>) if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							